

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	09/706,406	TAGG, JAMES P.
	<b>Examiner</b> Hai V. Nguyen	<b>Art Unit</b> 2142

**SEARCHED**

Class	Subclass	Date	Examiner
709	225,227	11/19/2005	HN
709	229	11/19/2005	HN
726	21	11/19/2005	HN
726	25	11/19/2005	HN
717	118	11/19/2005	HN
706	45	11/19/2005	HN
455	436	11/19/2005	HN
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370	353	11/19/2005	HN
370	235	11/19/2005	HN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner